



NSAI
Standards

Irish Standard
I.S. EN 60469:2013

Transitions, pulses and related waveforms - Terms, definitions and algorithms (IEC 60469:2013 (EQV))

I.S. EN 60469:2013

Incorporating amendments/corrigenda issued since publication:

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English version

**Transitions, pulses and related waveforms -
Terms, definitions and algorithms
(IEC 60469:2013)**

Transitions, impulsions et formes d'ondes
associées -
Termes, définitions et algorithmes
(CEI 60469:2013)

Übergänge, Impulse und zugehörige
Schwingungsabbilder - Begriffe,
Definitionen und Algorithmen
(IEC 60469:2013)

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CENELEC

European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

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Foreword

The text of document 85/409/CDV, future edition 1 of IEC 60469, prepared by IEC/TC 85 "Measuring equipment for electrical and electromagnetic quantities" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 60469:2013.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2014-02-28
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Endorsement notice

The text of the International Standard IEC 60469:2013 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

- | | | |
|----------------|------|---|
| ISO 9000:2005 | NOTE | Harmonised as EN ISO 9000:2005 (not modified). |
| ISO 10012:2003 | NOTE | Harmonised as EN ISO 10012:2003 (not modified). |

CONTENTS

FOREWORD.....	4
INTRODUCTION.....	6
1 Scope.....	7
2 Normative references	7
3 Terms, definitions and symbols	7
3.1 General	7
3.2 Terms and definitions	7
3.3 Symbols	25
3.4 Deprecated terms.....	25
4 Measurement and analysis techniques	26
4.1 General	26
4.2 Method of waveform measurement	26
4.3 Description of the waveform measurement process	27
4.4 Waveform epoch determination	28
4.4.1 Selection of waveform epoch	28
4.4.2 Exclusion of data from analysis	28
5 Analysis algorithms for <i>waveforms</i>	28
5.1 Overview and guidance	28
5.2 Selecting <i>state levels</i>	28
5.2.1 General	28
5.2.2 Data-distribution-based methods - Histograms.....	28
5.2.3 Data-distribution-based methods - Shorth estimator	31
5.2.4 Other methods.....	33
5.2.5 Algorithm switching.....	34
5.3 Determination of other single <i>transition waveform</i> parameters	34
5.3.1 General	34
5.3.2 Algorithm for calculating signed waveform amplitude	34
5.3.3 Algorithm for calculating percent reference levels	35
5.3.4 Algorithms for calculating reference level instants	35
5.3.5 Algorithm for calculating transition duration between x1 % and x2 % reference levels	36
5.3.6 Algorithm for calculating the undershoot and overshoot aberrations of step-like waveforms.....	36
5.3.7 Algorithm for calculating waveform aberrations	38
5.3.8 Algorithm for calculating transition settling duration	39
5.3.9 Algorithm for calculating transition settling error	40
5.4 Analysis of single and repetitive pulse waveforms	40
5.4.1 General	40
5.4.2 Algorithm for calculating pulse duration	40
5.4.3 Algorithm for calculating waveform period.....	40
5.4.4 Algorithm for calculating pulse separation.....	41
5.4.5 Algorithm for calculating duty factor.....	42
5.5 Analysis of compound waveforms.....	42
5.5.1 General	42
5.5.2 Waveform parsing	43
5.5.3 Subepoch classification	45
5.5.4 Waveform reconstitution	45

5.6	Analysis of impulse-like waveforms	46
5.6.1	Algorithm for calculating the impulse amplitude	46
5.6.2	Algorithm for calculating impulse center instant	46
5.7	Analysis of time relationships between different waveforms	46
5.7.1	General	46
5.7.2	Algorithm for calculating delay between different waveforms	46
5.8	Analysis of waveform aberration	46
5.9	Analysis of <i>fluctuation</i> and <i>jitter</i>	46
5.9.1	General	46
5.9.2	Determining standard deviations	47
5.9.3	Measuring fluctuation and jitter of an instrument	50
5.9.4	Measuring <i>fluctuation</i> and <i>jitter</i> of a <i>signal</i> source	53
Annex A (informative)	<i>Waveform</i> examples	54
	Bibliography	64
Figure 1	– Single <i>positive-going transition</i>	10
Figure 2	– Single <i>negative-going transition</i>	11
Figure 3	– Single <i>positive pulse waveform</i>	13
Figure 4	– Single <i>negative pulse waveform</i>	13
Figure 5	– <i>Overshoot</i> and <i>undershoot</i> in <i>single positive-going transition</i>	15
Figure 6	– <i>Overshoot</i> and <i>undershoot</i> in a <i>single negative-going transition</i>	15
Figure 7	– <i>Pulse train</i>	17
Figure 8	– <i>Compound waveform</i>	22
Figure 9	– Calculation of <i>waveform aberration</i>	23
Figure 10	– Waveform acquisition and measurement process	27
Figure 11	– Generation of a <i>compound waveform</i>	43
Figure A.1	– <i>Step-like waveform</i>	54
Figure A.2	– Linear <i>transition waveform</i>	55
Figure A.3	– Exponential <i>waveform</i>	56
Figure A.4	– <i>Impulse-like waveform</i>	57
Figure A.5	– Rectangular <i>pulse waveform</i>	58
Figure A.6	– Trapezoidal <i>pulse waveform</i>	59
Figure A.7	– Triangular <i>pulse waveform</i>	60
Figure A.8	– Exponential <i>pulse waveform</i>	61
Figure A.9	– Double <i>pulse waveform</i>	62
Figure A.10	– Bipolar <i>pulse waveform</i>	62
Figure A.11	– Staircase <i>waveform</i>	63
Figure A.12	– <i>Pulse train</i>	63
Table 1	– Comparison of the results from the exact and approximate formulas for computing the standard deviation of the calculated standard deviations	49

INTERNATIONAL ELECTROTECHNICAL COMMISSION

**TRANSITIONS, PULSES AND RELATED WAVEFORMS –
TERMS, DEFINITIONS AND ALGORITHMS**

FOREWORD

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International Standard IEC 60469 has been prepared by IEC technical committee 85: Measuring equipment for electrical and electromagnetic quantities.

This first edition of IEC 60469 cancels and replaces the second edition of IEC 60469-1 and the second edition of IEC 60469-2, both published in 1987. It constitutes a technical revision.

This first edition of IEC 60469:

- combines the contents of IEC 60469-1:1987 and IEC 60469-2:1987;
- updates terminology;
- adds algorithms for computing values of pulse parameters;
- adds a newly-developed method for computing state levels.

The text of this standard is based on the following documents:

CDV	Report on voting
85/409/CDV	85/433/RVC

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

All terms defined in Clause 3 are italicized in this document.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

INTRODUCTION

The purpose of this standard is to facilitate accurate and precise communication concerning parameters of transition, pulse, and related waveforms and to establish the techniques and procedures for measuring them. Because of the broad applicability of electrical pulse technology in the electronics industries (such as computer, telecommunication, and test instrumentation industries), the development of unambiguous definitions for pulse terms and the presentation of methods and/or algorithms for their calculation is important for communication between manufacturers and consumers within the electronics industry. The availability of standard terms, definitions, and methods for their computation helps improve the quality of products and helps the consumer better compare the performance of different products. Improvements to digital waveform recorders (including oscilloscopes) have facilitated the capture, sharing, and processing of waveforms. Frequently these waveform recorders have the ability to process the waveform internally and provide pulse parameters. This process is done automatically and without operator intervention. This standard can be applied in many more scientific and engineering applications than mentioned above, such as optics, cosmology, seismology, medicine, etc., and ranging from single events to highly repetitive signals and from signals with bandwidths less than 1 Hz to those exceeding 1 THz. Consequently, a standard is needed to ensure that the definitions and methods of computation for pulse parameters are consistent.

IEC 60469-1 dealt with terms and definitions for describing waveform parameters and IEC 60469-2 described the waveform measurement process. The purpose of this standard is to combine the contents of IEC 60469-1 and IEC 60469-2, update terminology, correct errors, add algorithms for computing values of pulse parameters, and add a newly-developed method for computing state levels. This standard reflects two major changes compared to IEC 60469-1 and IEC 60469-2, which are the parameter definitions and algorithms. Changes to the definitions included adding new terms and definitions, deleting unused terms and definitions, expanding the list of deprecated terms, and updating and modifying existing definitions. This standard contains definitions for approximately 100 terms commonly used to describe the waveform measurement and analysis process and waveform parameters. Many of the terms in standards IEC 60469-1 and IEC 60469-2 have been deleted entirely or deprecated. Deprecated terms were kept in this standard to provide continuity between this standard and IEC 60469-1 and IEC 60469-2. Terms are deprecated whenever they cannot be defined unambiguously or precisely. Development of a set of agreed-upon terms and definitions presented the greatest difficulty because of the pervasive misuse, misrepresentation, and misunderstanding of terms. Legacy issues for instrumentation manufacturers and terms of common use also had to be addressed. This standard also resulted in the development of algorithms for computing the values of certain waveform parameters in all cases where these algorithms could be useful or instructive to the user of the standard. The purpose of adding these algorithms, which are recommended for use, was to provide industry with a common and communicable reference for these parameters and their computation. Heretofore, this was not available and there existed much debate and misunderstanding between various groups measuring the same parameters. Similarly, this is the reason for including several examples of basic waveforms, with formulae, in Annex A. The algorithms focus on the analysis of two-state, single-transition waveforms. The analysis of compound waveforms (waveforms with two or more states and/or two or more transitions) is accomplished by first decomposing the compound waveform into its constituent two-state single-transition waveforms. A method for performing this decomposition is provided.

Algorithms for the analysis of fluctuation and random jitter of waveforms were also introduced into this standard. These algorithms describe the computation of the mean and standard deviation of jitter and fluctuation. This standard also contains methods to estimate the *accuracy* of the standard deviation and to correct its value.

TRANSITIONS, PULSES AND RELATED WAVEFORMS – TERMS, DEFINITIONS AND ALGORITHMS

1 Scope

This International Standard provides definitions of terms pertaining to transitions, pulses, and related waveforms and provides definitions and descriptions of techniques and procedures for measuring their parameters. The waveforms considered in this standard are those that make a number of transitions and that remain relatively constant in the time intervals between transitions. Signals and their waveforms for which this standard apply include but are not limited to those used in: digital communications, data communications, and computing; studies of transient biological, cosmological, and physical events; and electrical, chemical, and thermal pulses encountered and used in a variety of industrial, commercial, and consumer applications.

This standard does not apply to sinusoidally-varying or other continuously-varying signals and their waveforms.

The object of this standard is to facilitate accurate and precise communication concerning parameters of transitions, pulses, and related waveforms and the techniques and procedures for measuring them.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

None.

3 Terms, definitions and symbols

3.1 General

Along with the recommended terms and their definitions, this clause also contains a number of deprecated but widely used terms. These deprecated terms and the reason for their deprecation are given after the definition of the recommended term.

Throughout this standard, time is taken to be an independent variable, symbolized with the letter t . "Waveform value" is used to refer to the dependent variable, symbolized by $y(t)$. For particular waveforms, "waveform value" will be synonymous with terms such as "voltage", "current", "power", or some other quantity. All defined terms are italicized in this document.

3.2 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

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